

2nd method. - DT version of the CT method

- computes the area of overlap between one signal and the flipped and shifted version of the other.

Step 1: Draw $x_1[k]$, $x_2[-k]$ and an output axis for $y[n]$.

Step 2: Slide $x_2[n-k]$ across $x_1[k]$ and compute $y[n]$ as the "area" of overlap.

$$x_1[n] = \text{rect}_3[n]$$



$$x_2[n] = \text{rect}_2[n]$$

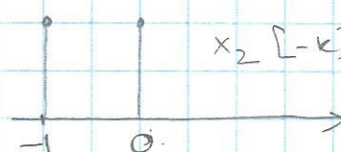


Step 1

$x_1[k]$



$x_2[-k]$



Step 2

Slide $x_2[n-k]$ across $x_1[k]$, compute $y[n]$ as area of overlap

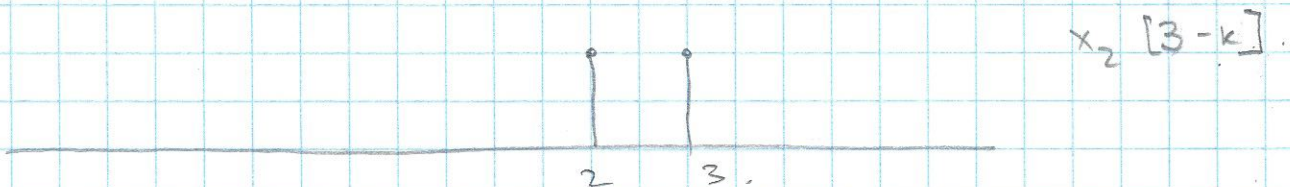
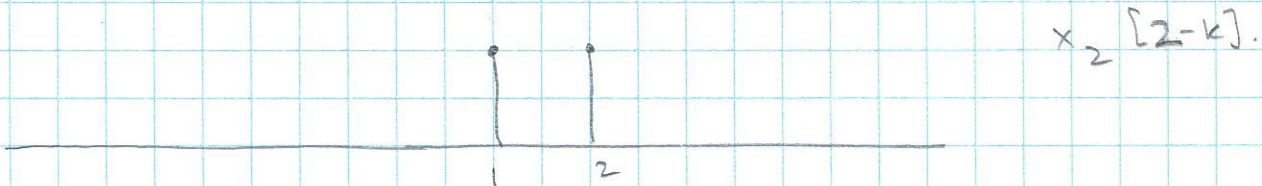
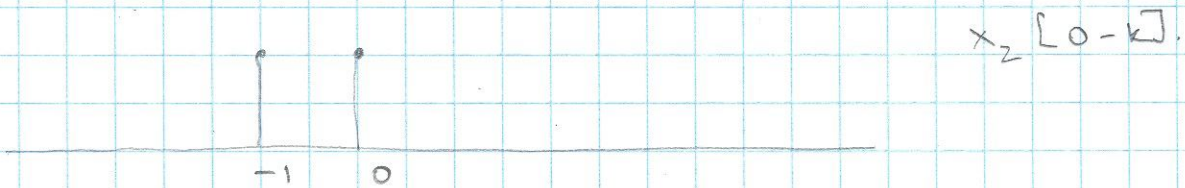
$y[n]$



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$$y[m] = 0 \text{ for } m < 0.$$

$$m=0.$$

$$y[0] = 1.$$

$$m=1$$

$$y[1] = 2.$$

$$m=2$$

$$y[2] = 2.$$

$$m=3$$

$$y[3] = 1.$$

$$y[m] = 0 \text{ for } m > 3.$$

